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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Micha Gutman, et al

Application No.:

10/659,042

Group No.:2812

Filing Date:

September 9, 2003

Examiner: Richard A. Booth

For: "METHOD OF DECREASING CHARGING EFFECTS IN OXIDE-NITRIDE-OXIDE (ONO) MEMORY ARRAYS"

Date: October 22, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

STATUS INQUIRY

- 1. More than twelve months have passed since the filing of this application on September 9, 2003. No communication has been received from the Patent and Trademark Office indicating action on this application.
- 2. Kindly advise the undersigned of the present status of this application.

SIGNATURE OF PRACTITIONER

E. Eric Hoffman Reg. No. 38,186

BEVER, HOFFMAN & HARMS, LLP

Tel. No.: (925) 895-3545 Fax No.: (925) 371-8187 Customer No.: 22888